

ADC1001/ADC1021 10-Bit μ P Compatible A/D Converters

General Description

The ADC1001 and ADC1021 are CMOS, 10-bit successive approximation A/D converters. The 20-pin ADC1001 is pin compatible with the ADC0801 8-bit A/D family. The 10-bit data word is read in two 8-bit bytes, formatted left justified and high byte first. The six least significant bits of the second byte are set to zero, as is proper for a 16-bit word.

The 24-pin ADC1021 outputs 10 bits parallel and is intended for interface to a 16-bit data bus.

Differential inputs provide low frequency input common mode rejection and allow offsetting the analog range of the converter. In addition, the reference input can be adjusted enabling the conversion of reduced analog ranges with 10bit resolution.

Features

- ADC1001 is pin compatible with ADC0801 series 8-bit A/D converters
- Compatible with NSC800 and 8080 µP derivatives—no interfacing logic needed

- Easily interfaced to 6800 µP derivatives with minimal external logic
- Differential analog voltage inputs
- Logic inputs and outputs meet both MOS and TTL voltage level specifications
- Works with 2.5V (LM336) voltage reference
- On-chip clock generator
- 0V to 5V analog input voltage range with single 5V sup-
- Operates ratiometrically or with 5 V_{DC}, 2.5 V_{DC}, or analog span adjusted voltage reference
- 0.3" standard width 20-pin DIP package or 24 pins with 10-bit parallel output

Key Specifications

- Resolution
- Linearity error

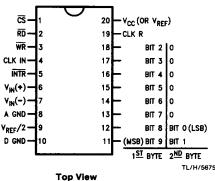
10 bits ±1 LSB

■ Conversion time

200µS

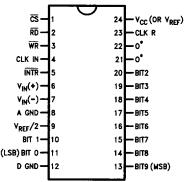
Connection Diagrams

ADC1001 (for an 8-bit data bus) **Dual-In-Line Package**



TL/H/5675-11

ADC1021 (for all 10-bit outputs in parallel) **Dual-In-Line Package**



TL/H/5675-12

Top View *TRI-STATE output buffers which output 0 during RD.

Ordering Information

Temperature Range	0°C to	+ 70°C	-40°C to +85°C			
Order Number	ADC1001CCJ-1	ADC1021CCJ-1	ADC1001CCJ	ADC1021CCJ		
Package Outline	J20A	J24A	J20A	J24A		

Absolute Maximum Ratings (Notes 1 & 2)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/Distributors for availability and specifications.

Supply Voltage (V_{CC}) (Note 3) 6.5V

Logic Control Inputs -0.3V to +18V

Voltage at Other Inputs and Outputs -0.3V to (V_{CC}+0.3V)

Storage Temperature Range -65°C to +150°C
Package Dissipation at T_A = 25°C 875 mW

Package Dissipation at T_A = 25°C 875 mW Lead Temp. (Soldering, 10 seconds) 300°C

ESD Susceptibility (Note 10) 800V

Operating Conditions (Notes 1 & 2)

Temperature Range $T_{MIN} \le T_A \le T_{MAX}$ ADC1001CCJ $-40^{\circ}\text{C} \le T_A \le +85^{\circ}\text{C}$

ADC1021CCJ ADC1001CCJ-1

ADC1001CCJ-1 0° C \leq T_A \leq + 70 $^{\circ}$ C ADC1021CCJ-1

Range of V_{CC} 4.5 V_{DC} to 6.3 V_{DC}

Converter Characteristics

Converter Specifications: $V_{CC} = 5 V_{DC}$, $V_{REF}/2 = 2.500 V_{DC}$, $T_{MIN} \le T_A \le T_{MAX}$ and $f_{CLK} = 410$ kHz unless otherwise specified.

Parameter	Conditions	Min	Тур	Max	Units
ADC1001C, ADC1021C:					
Linearity Error		1	*	±1	LSB
Zero Error			i	±2	LSB
Full-Scale Error				±2	LSB
Total Ladder Resistance (Note 9)	Input Resistance at Pin 9	2.2	4.8		ΚΩ
Analog Input Voltage Range	(Note 4) V(+) or V(−)	GND-0.05		V _{CC} +0.05	V _{DC}
DC Common-Mode Error	Over Analog Input Voltage Range		± 1/8		LSB
Power Supply Sensitivity	V _{CC} =5 V _{DC} ±5% Over Allowed V _{IN} (+) and V _{IN} (-) Voltage Range (Note 4)		± 1/8		LSB

AC Electrical Characteristics

Timing Specifications: V_{CC}=5 V_{DC} and T_A=25°C unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Units
T _c	Conversion Time	(Note 5) f _{CLK} = 410 kHz	80 195		90 220	1/f _{CLK} μs
fCLK	Clock Frequency	(Note 8)	100		1260	kHz
	Clock Duty Cycle		40		60	%
CR	Conversion Rate In Free-Running Mode	INTR tied to WR with CS=0 V _{DC} , f _{CLK} =410 kHz			4600	conv/s
tw(WR)L	Width of WR Input (Start Pulse Width)	CS = 0 V _{DC} (Note 6)	150			ns
tacc	Access Time (Delay from Falling Edge of RD to Output Data Valid)	C _L = 100 pF		170	300	ns
t _{1H} , t _{0H}	TRI-STATE® Control (Delay from Rising Edge of RD to Hi-Z State)	C _L =10 pF, R _L =10k (See TRI-STATE Test Circuits)		125	200	ns
t _{Wi} , t _{Ri}	Delay from Falling Edge of WR or RD to Reset of INTR			300	450	ns
t _{1rs}	INTR to 1st Read Set-Up Time		550	400		ns
C _{IN}	Input Capacitance of Logic Control Inputs			5	7.5	pF
C _{OUT}	TRI-STATE Output Capacitance (Data Buffers)			5	7.5	pF

DC Electrical Characteristics

The following specifications apply for $V_{CC}=5~V_{DC}$ and $T_{MIN}\leq T_{A}\leq~T_{MAX}$, unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Units
CONTROL	INPUTS [Note: CLK IN is the input	of a Schmitt trigger circuit and is the	refore spec	cified separate	ely]	•
V _{IN} (1)	Logical "1" Input Voltage (Except CLK IN)	V _{CC} =5.25 V _{DC}	2.0		15	V _{DC}
V _{IN} (0)	Logical "0" Input Voltage (Except CLK IN)	V _{CC} =4.75 V _{DC}			0.8	V _{DC}
I _{IN} (1)	Logical "1" Input Current (All Inputs)	V _{IN} = 5 V _{DC}		0.005	1	μA _{DC}
I _{IN} (0)	Logical "0" input Current (All Inputs)	V _{IN} =0 V _{DC}	-1	-0.005		μA _{DC}
CLOCK IN						•
V _T +	CLK IN Positive Going Threshold Voltage		2.7	3.1	3.5	V _{DC}
V _T -	CLK IN Negative Going Threshold Voltage		1.5	1.8	2.1	V _{DC}
V _H	CLK IN Hysteresis (V _T +)-(V _T -)		0.6	1.3	2.0	V _{DC}
OUTPUTS	AND INTR					L
V _{OUT} (0)	Logical "0" Output Voltage	I _{OUT} = 1.6 mA, V _{CC} = 4.75 V _{DC}			0.4	V _{DC}
V _{OUT} (1)	Logical "1" Output Voltage	$I_O = -360 \mu A$, $V_{CC} = 4.75 V_{DC}$ $I_O = -10 \mu A$, $V_{CC} = 4.75 V_{DC}$	2.4 4.5			V _{DC}
lout	TRI-STATE Disabled Output Leakage (All Data Buffers)	$V_{OUT} = 0.4 V_{DC}$ $V_{OUT} = 5 V_{DC}$		0.1 0.1	-100 3	μA _{DC} μ A _{DC}
ISOURCE		V _{OUT} Short to GND, T _A = 25°C	4.5	6		mA _{DC}
Isink		V _{OUT} Short to V _{CC} , T _A = 25°C	9.0	16		mA _{DC}
POWER SU	IPPLY					
lcc	Supply Current (Includes Ladder Current)	f _{CLK} = 410 kHz, V _{REF} /2 = NC, T _A = 25°C and CS = 1		2.5	5.0	mA

Note 1: Absolute Maximum Ratings indicate limits beyond which damage to the device may occur. DC and AC electrical specifications do not apply when operating the device beyond its specified operating conditions.

Note 2: All voltages are measured with respect to GND, unless otherwise specified. The separate A GND point should always be wired to the D GND.

Note 3: A zener diode exists, internally, from V_{CC} to GND and has a typical breakdown voltage of 7 V_{DC}.

Note 4: For V_{IN}(−)≥ V_{IN}(+) the digital output code will be all zeros. Two on-chip diodes are tied to each analog input (see Block Diagram) which will forward conduct for analog input voltages one diode drop below ground or one diode drop greater than the V_{CC} supply. Be careful, during testing at low V_{CC} levels (4.5V_A) as high level analog inputs not good are full-scale. The spec allows 50 mV forward bias of either diode. This means that as long as the analog V_{IN} does not exceed the supply voltage by more than 50 mV, the output code will be correct. To achieve an absolute 0 V_{DC} to 5 V_{DC} input voltage range will therefore require a minimum supply voltage of 4.950 V_{DC} over temperature variations, initial tolerance and loading.

Note 5: With an asynchronous start pulse, up to 8 clock periods may be required before the internal clock phases are proper to start the conversion process. The start request is internally latched, see Figure 1.

Note 6: The \overline{CS} input is assumed to bracket the \overline{WR} strobe input and therefore timing is dependent on the \overline{WR} pulse width. An arbitrarily wide pulse width will hold the converter in a reset mode and the start of conversion is initiated by the low to high transition of the \overline{WR} pulse (see Timing Diagrams).

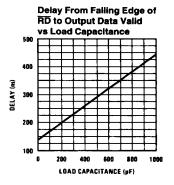
Note 7: All typical values are for TA = 25°C.

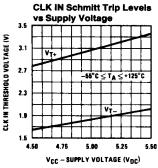
Note 8: Accuracy is guaranteed at f_{CLK}=410 kHz. At higher clock frequencies accuracy can degrade.

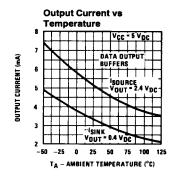
Note 9: The V_{REF/2} pin is the center point of a two resistor divider (each resistor is 2.4k Ω) connected from V_{CC} to ground. Total ladder input resistance is the sum of these two equal resistors.

Note 10: Human body model, 100 pF discharged through a 1.5 k Ω resistor.

Typical Performance Characteristics

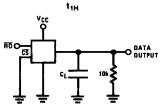




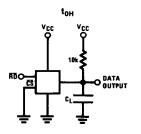


TL/H/5675-2

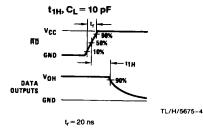
TRI-STATE Test Circuits and Waveforms



TL/H/5675-3



TL/H/5675-5



TOH, CL = 10 pF

VCC

RD

GND

DATA

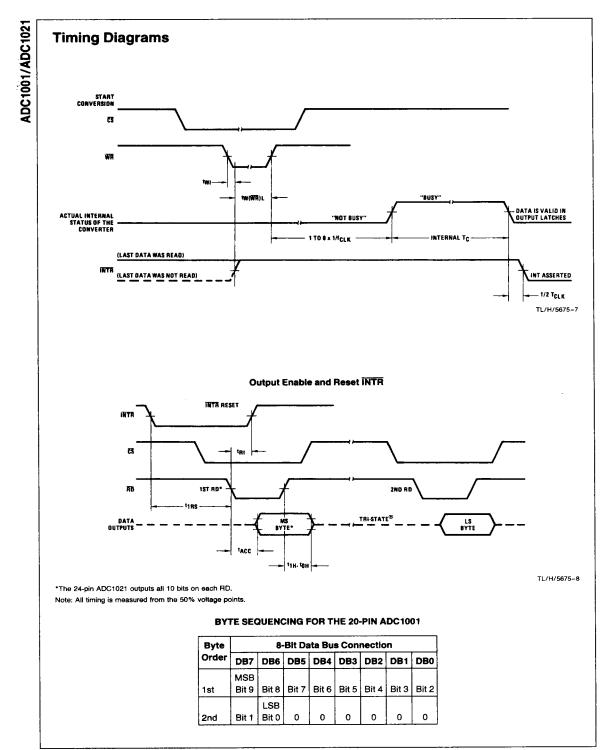
OUTPUTS

V₀L

10%

10%

TL/H/5675-6



Functional Description

The ADC1001, ADC1021 use an advanced potentiometric resistive ladder network. The analog inputs, as well as the taps of this ladder network, are switched into a weighted capacitor array. The output of this capacitor array is the input to a sampled data comparator. This comparator allows the successive approximation logic to match the analog difference input voltage $[V_{IN}(+)-V_{IN}(-)]$ to taps on the R network. The most significant bit is tested first and after 10 comparisons (80 clock cycles) a digital 10-bit binary code (all "1"s = full-scale) is transferred to an output latch and then an interrupt is asserted (INTR makes a high-to-low transition). The device may be operated in the free-running mode by connecting INTR to the WR inut with CS=0. To ensure start-up under all possible conditions, an external WR pulse is required during the first power-up cycle. A conversion in process can be interrupted by issuing a second start command.

On the high-to-low transition of the \overline{WR} input the internal SAR latches and the shift register stages are reset. As long as the \overline{CS} input and \overline{WR} input remain low, the A/D will remain in a reset state. Conversion will start from 1 to 8 clock periods after at least one of these inputs makes a low-to-high transition.

A functional diagram of the A/D converter is shown in *Figure 1*. All of the inputs and outputs are shown and the major logic control paths are drawn in heavier weight lines.

The conversion is initialized by taking \overline{CS} and \overline{WR} simultaneously low. This sets the start flip-flop (F/F) and the resulting "1" level resets the 8-bit shift register, resets the Interrupt (INTR) F/F and inputs a "1" to the D flop, F/F1, which is at the input end of the 10-bit shift register. Internal clock signals then transfer this "1" to the Q output of F/F1. The AND gate, G1, combines this "1" output with a clock signal to provide a reset signal to the start F/F. If the set signal is no longer present (either \overline{WR} or \overline{CS} is a "1") the start F/F is reset and the 10-bit shift register then can have the "1"

10k V_{IN} (+)
ADC1001, ADC1021
V_{IN}(-)
TI /H/5675-8

NOTE: $V_{IN}(-)$ should be biased so that $V_{IN}(-) \ge -0.05V$ when potentiometer wiper is set at most negative voltage position.

FIGURE 2. Zero Adjust Circuit

clocked in, which allows the conversion process to continue. If the set signal were to still be present, this reset pulse would have no effect and the 10-bit shift register would continue to be held in the reset mode. This logic therefore allows for wide \overline{CS} and \overline{WR} signals and the converter will start after at least one of these signals returns high and the internal clocks again provide a reset signal for the start F/F.

After the "1" is clocked through the 10-bit shift register (which completes the SAR search) it causes the new digital word to transfer to the TRI-STATE output latches. When this XFER signal makes a high-to-low transition the one shot fires, setting the INTR F/F. An inverting buffer then supplies the INTR output signal.

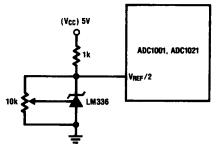
Note that this SET control of the INTR F/F remains low for aproximately 400 ns. If the data output is continuously enabled (CS and RD both held low), the INTR output will still signal the end of the conversion (by a high-to-low transition), because the SET input can control the Q output of the INTR F/F even though the RESET input is constantly at a "1" level. This INTR output will therefore stay low for the duration of the SET signal.

When data is to be read, the combination of both $\overline{\text{CS}}$ and $\overline{\text{RD}}$ being low will cause the INTR F/F to be reset and the TRI-STATE output latches will be enabled.

Zero and Full-Scale Adjustment

Zero error can be adjusted as shown in Figure 2. $V_{IN}(+)$ is forced to +2.5 mV $(+\frac{1}{2}$ LSB) and the potentiometer is adjusted until the digital output code changes from 00 0000 0000 to 00 0000 0001.

Full-scale is adjusted as shown in Figure 3, with the $V_{REF}/2$ input. With V_{IN} (+) forced to the desired full-scale voltage less 1½ LSBs ($V_{FS}-11/2$ LSBs), $V_{REF}/2$ is adjusted until the digital output code changes from 11 1111 1110 to 11 1111 1111.



TL/H/5675-10

FIGURE 3. Full-Scale Adjust